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| FORM HDP-1449 (Based on Form PTO-1449) PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION (Use several sheets if necessary) Sheet 1 of 1 | ATTORNEY DOCKET No. | SERIAL No. |
| | 5077-000046 | Not yet assigned |
| | APPLICANT | |
| | Shusaku Okamoto | |
| | FILING DATE | GROUP |
| Herewith | | |

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 09/866082
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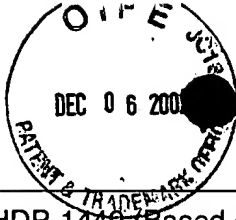
| U.S. PATENT DOCUMENTS | | | | | | |
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| Ref. Desig. | Examiner's Initials | Document Number | Date | Name | Class/ Subclass | (If appropriate) Filing Date |
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| FOREIGN PATENT DOCUMENTS | | | | | | |
|--------------------------|---------------------|-----------------|----------|---------|-------------------|--------------------|
| Ref. Desig. | Examiner's Initials | Document Number | Date | Country | Class/ Subclass | Translation Yes No |
| 1. | <i>WJ</i> | 11-078692 | 03/23/99 | Japan | | X Abstract |

| OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.) | | |
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| Examiner: <i>[Signature]</i> | Date Considered: <i>7/21/09</i> |
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FORM HDP-1449 (Based on Form PTO-1449)

**PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION**

(Use several sheets if necessary)

Sheet 1 of 1

| | |
|-------------------------|------------|
| ATTORNEY DOCKET NO. | SERIAL NO. |
| 5077-000046 | 09/866,082 |
| APPLICANT | |
| Shusaku Okamoto, et al. | |
| FILING DATE | GROUP |
| May 25, 2001 | 2612 |

U.S. PATENT DOCUMENTS

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| 1. | W | 11-078692 | 03/1999 | Japan | | Abstract | |

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Examiner:

[Signature]

Date Considered:

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